HAT2093R

Silicon N Channel Power MOS FET High Speed Power Switching

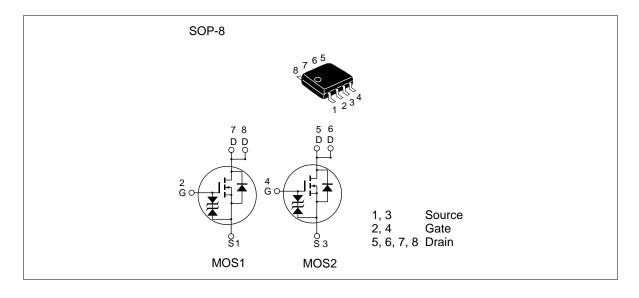
HITACHI

ADE-208-1237A (Z) 2nd. Edition Jan. 2001

Features

- Low on-resistance
- Capable of 4.5 V gate drive
- Low drive current
- High density mounting

Outline





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Absolute Maximum Ratings $(Ta = 25^{\circ}C)$

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	30	V
Gate to source voltage	$V_{\rm GSS}$	±20	V
Drain current	I _D	9	A
Drain peak current	Note1	72	A
Body-drain diode reverse drain current	I _{DR}	9	A
Channel dissipation	Pch Note2	2	W
Channel dissipation	Pch Note3	3	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note:

- 1. PW \leq 10 μ s, duty cycle \leq 1 %
- 2. 1 Drive operation : When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW \leq 10s
- 3. 2 Drive operation : When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW \leq 10s

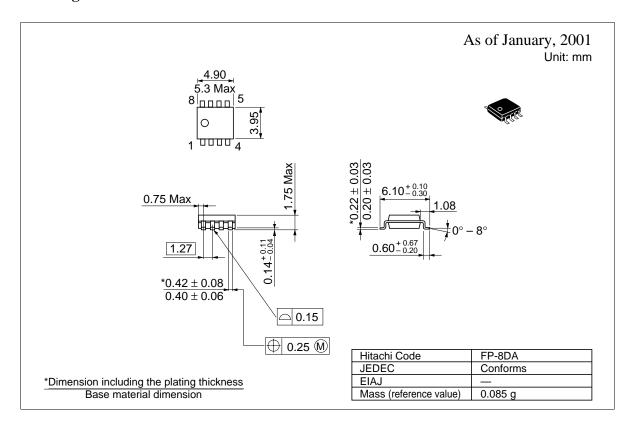
Electrical Characteristics ($Ta = 25^{\circ}C$)

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	30	_	_	V	$I_{D} = 10 \text{mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	± 20	_	_	V	$I_{G} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}	_	_	1	μΑ	$V_{DS} = 30 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	_	2.5	V	$V_{DS} = 10V$, $I_{D} = 1mA$
Static drain to source on state	$R_{\text{DS(on)}}$	_	18	23	$m\Omega$	$I_D = 4.5A, V_{GS} = 10V^{Note4}$
resistance	$R_{\text{DS(on)}}$	_	27	39	$m\Omega$	$I_D = 4.5A, V_{GS} = 4.5V^{Note4}$
Forward transfer admittance	$ y_{fs} $	9	15	_	S	$I_{\rm D} = 4.5 {\rm A}, V_{\rm DS} = 10 {\rm V}^{\rm Note4}$
Input capacitance	Ciss	_	750	_	pF	$V_{DS} = 10V$
Output capacitance	Coss	_	200	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	110	_	pF	f = 1MHz
Total gate charge	Qg	_	12	_	nc	$V_{DD} = 10 \text{ V}$
Gate to source charge	Qgs	_	2.3	_	nc	$V_{GS} = 10 \text{ V}$
Gate to drain charge	Qgd	_	2.2	_	nc	I _D = 9 A
Turn-on delay time	$t_{\text{d(on)}}$	_	11	_	ns	$V_{GS} = 10A, I_{D} = 4.5A$
Rise time	t _r	_	16	_	ns	$V_{DD} \cong 10V$
Turn-off delay time	$t_{d(off)}$	_	40	_	ns	$R_L = 2.22\Omega$
Fall time	t _f	_	7	_	ns	$R_g = 4.7\Omega$
Body-drain diode forward voltage	V_{DF}	_	0.85	1.10	V	$IF = 9A$, $V_{GS} = 0$ Note4
Body-drain diode reverse recovery time	t _{rr}	_	50	_	ns	$IF = 9A$, $V_{GS} = 0$ diF/ dt =50A/ μ s

Note: 4. Pulse test

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Package Dimensions



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